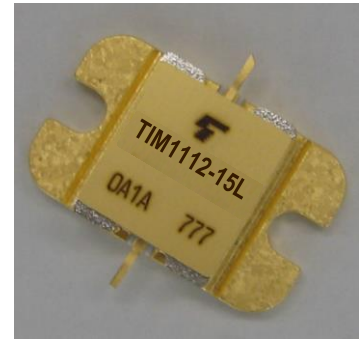


### FEATURES

- BROAD BAND INTERNALLY MATCHED FET
- HIGH POWER  
P1dB= 42.0dBm at 11.7GHz to 12.7GHz
- HIGH GAIN  
G1dB= 6.0dB at 11.7GHz to 12.7GHz
- LOW INTERMODULATION DISTORTION  
IM3= -45dBc at Pout= 30.0dBm  
Single Carrier Level
- HERMETICALLY SEALED PACKAGE



### RF PERFORMANCE SPECIFICATIONS ( Ta= 25°C )

| CHARACTERISTICS                            | SYMBOL | CONDITIONS   | UNIT | MIN. | TYP. | MAX. |
|--|--------|--|------|------|------|------|
| Output Power at 1dB Gain Compression Point | P1dB   | VDS= 9V<br>IDSset= 4.0A<br>f = 11.7 to 12.7GHz                   | dBm  | 41.0 | 42.0 | —    |
| Power Gain at 1dB Gain Compression Point   | G1dB   |  | dB   | 5.0  | 6.0  | —    |
| Drain Current                              | IDS1   |  | A    | —    | 4.5  | 5.5  |
| Gain Flatness                              | ΔG     |  | dB   | —    | —    | ±0.8 |
| Power Added Efficiency                     | ηadd   |  | %    | —    | 29   | —    |
| 3rd Order Intermodulation Distortion       | IM3    | Two Tone Test<br>Po= 30.0dBm, Δf= 5MHz<br>(Single Carrier Level) | dBc  | -42  | -45  | —    |
| Drain Current                              | IDS2   |  | A    | —    | 4.5  | 5.5  |
| Channel Temperature Rise                   | ΔTch   | (VDS X IDS + Pin – P1dB) X Rth(c-c)                              | °C   | —    | —    | 100  |

**Recommended Gate Resistance(Rg): 100 Ω**

### ELECTRICAL CHARACTERISTICS ( Ta= 25°C )

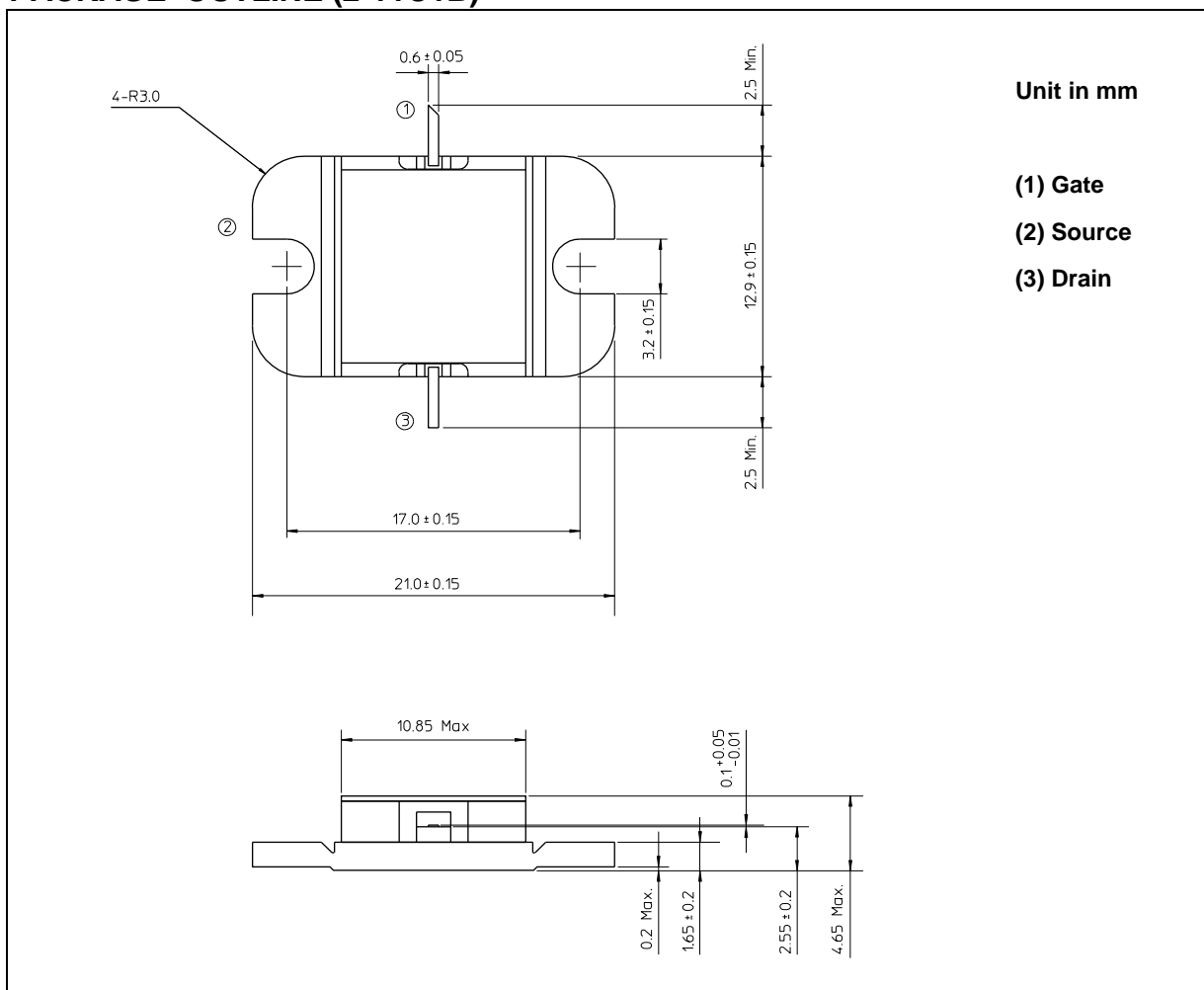
| CHARACTERISTICS               | SYMBOL   | CONDITIONS            | UNIT | MIN. | TYP. | MAX. |
|-------------------------------|----------|-----------------------|------|------|------|------|
| Transconductance              | gm       | VDS= 3V<br>IDS= 4.8A  | S    | —    | 3.0  | —    |
| Pinch-off Voltage             | VGSoff   | VDS= 3V<br>IDS= 145mA | V    | -1.5 | -3.0 | -4.5 |
| Saturated Drain Current       | IDSS     | VDS= 3V<br>VGS= 0V    | A    | —    | 10.0 | 11.5 |
| Gate-Source Breakdown Voltage | VGSO     | IGS= -145μA           | V    | -5   | —    | —    |
| Thermal Resistance            | Rth(c-c) | Channel to Case       | °C/W | —    | 2.0  | 2.5  |

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**ABSOLUTE MAXIMUM RATINGS (Ta= 25°C)**

| CHARACTERISTICS                    | SYMBOL | UNIT | RATING      |
|------------------------------------|--------|------|-------------|
| Drain-Source Voltage               | VDS    | V    | 15          |
| Gate-Source Voltage                | VGS    | V    | -5          |
| Drain Current                      | IDS    | A    | 11.5        |
| Total Power Dissipation (Tc= 25°C) | PT     | W    | 60          |
| Channel Temperature                | Tch    | °C   | 175         |
| Storage                            | Tstg   | °C   | -65 to +175 |

**PACKAGE OUTLINE (2-11C1B)**

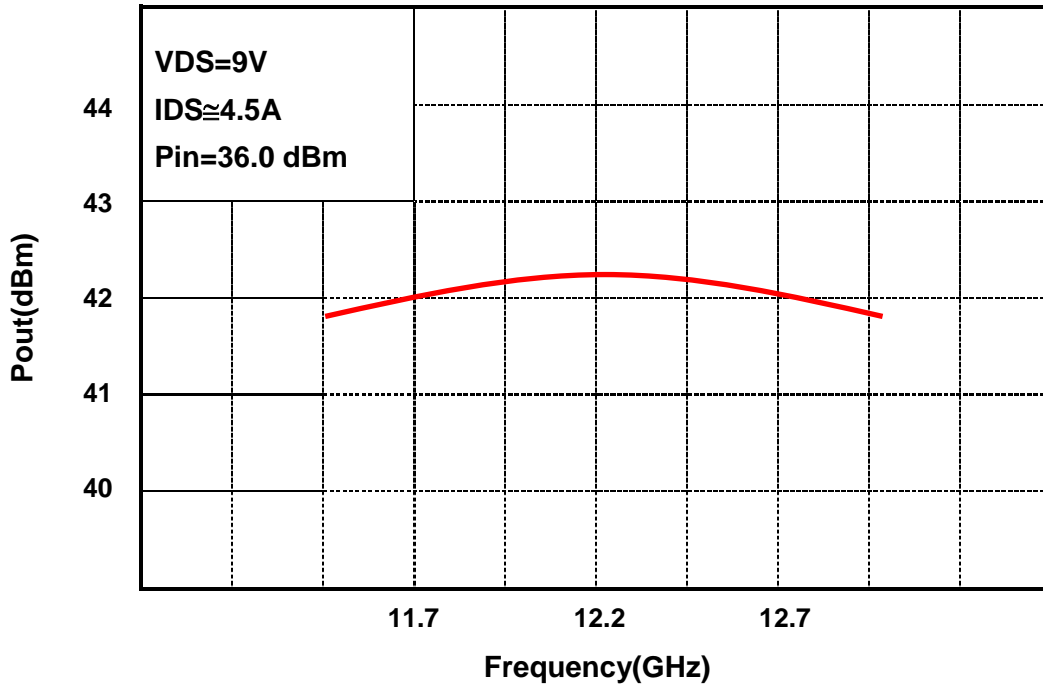


**HANDLING PRECAUTIONS FOR PACKAGE MODEL**

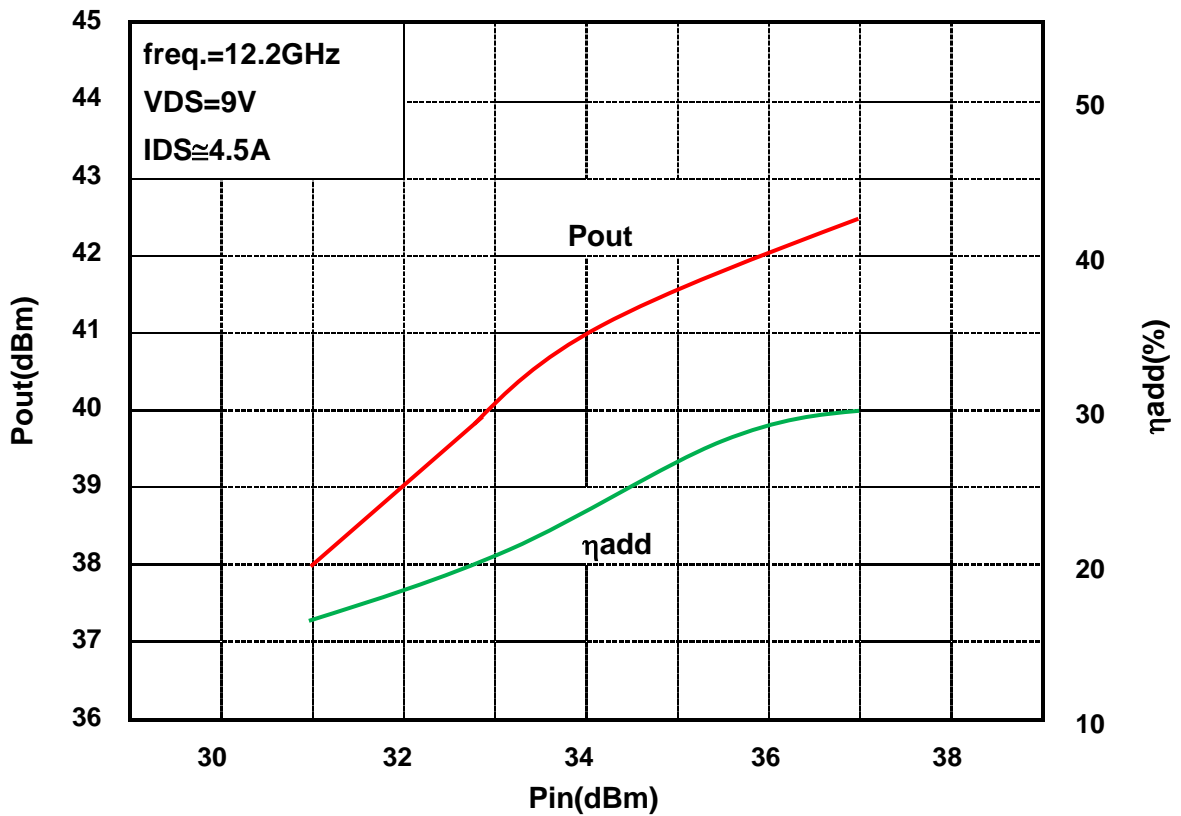
Soldering iron should be grounded and the operating time should not exceed 10 seconds at 260°C or 3 seconds at 350°C.

**RF PERFORMANCE**

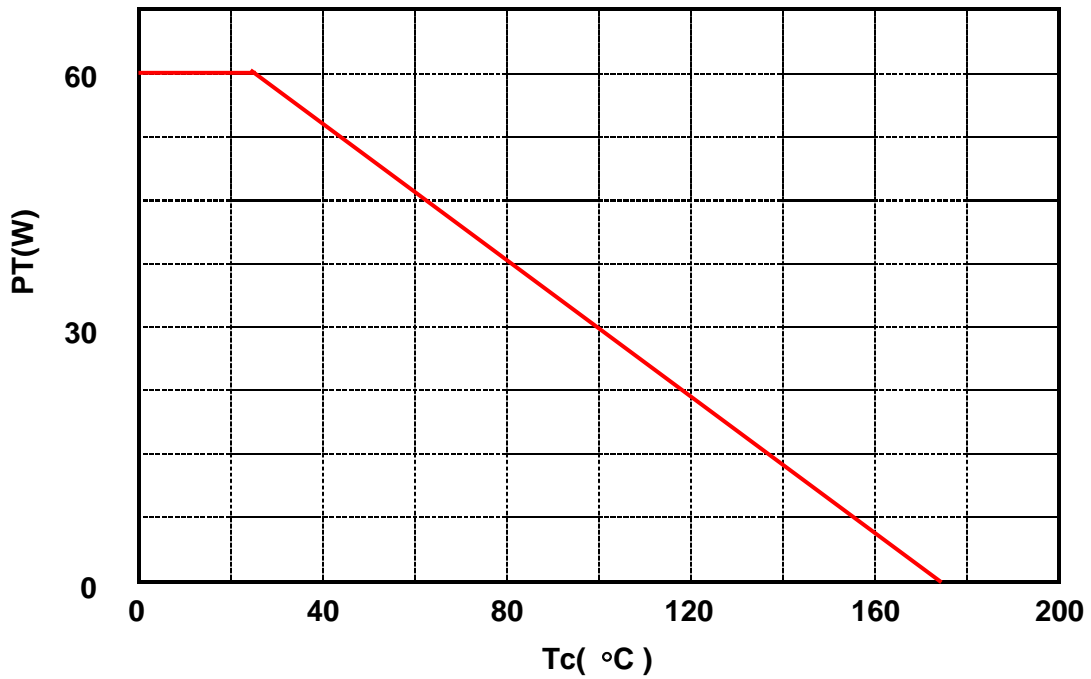
**Output Power (Pout) vs. Frequency**



**Output Power(Pout) vs. Input Power(Pin)**



**Power Dissipation(PT) vs. Case Temperature(Tc)**



**IM3 vs. Output Power Characteristics**

